

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. SERIAL NO.

107314-00024 09/928,454

APPLICANT

Harubiko MURATA et al.

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

Haruhiko MURATA, et al.						
FILING DATE	GROUP					
August 14, 2001	2613					

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EXAMINER'S INITIALS		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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400	АМ	Tetsuya KUNO, et al, "Aliasing Reduction Method For Color Digital Still Cameras With A Single-Chip Charge-Coupled Device", Journal of Electronic Imaging, Vol. 8, No. 4, Pages 457-465, October 4, 1999
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Sheet 1 of 1

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